

## Product Summary

$V_{(BR)CES}$	$V_{CE(SAT)MAX}$	$I_c$
650V	1.9V@15V	50A

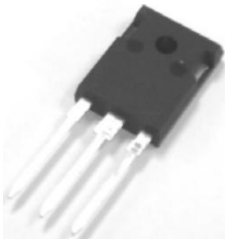
## Feature

- High speed smooth switching device for hard & soft switching
- Positive temperature coefficient
- High ruggedness, temperature stable

## Application

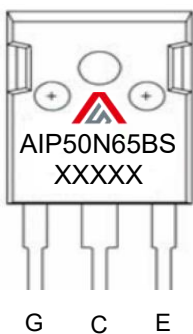
- Solar converters
- Welding converters
- Mid to high range switching frequency converters
- Uninterruptible power supply

## Package

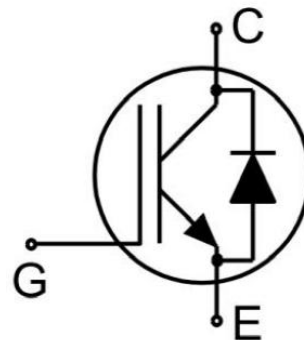


TO-247AB

## Marking



## Circuit diagram



### Absolute maximum ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Collector-Emitter Voltage	$V_{CE}$	650	V
Continuous Gate- Emitter Voltage	$V_{GE}$	±20	V
Collector Current	$I_C$	80	A
Collector Current(T <sub>C</sub> =100°C)	$I_C(100^\circ\text{C})$	50	A
Pulsed Collector Current, tp limited by T <sub>Jmax</sub> , V <sub>GE</sub> =15V	$I_{CM}$	200	A
Diode Continuous Forward Current	$I_F$	80	A
Diode Continuous Forward Current(T <sub>C</sub> =100°C)	$I_F(100^\circ\text{C})$	50	A
Diode Forward Pulsed Current,tp limited by T <sub>Jmax</sub>	$I_{Fpuls}$	200	A
Turn off Safe Operating Area V <sub>CE</sub> ≤650V, T <sub>J</sub> ≤150°C	-	200	A
Power Dissipation(T <sub>J</sub> =175°C)	$P_D$	283	W
Thermal Resistance, Junction to case for Diode	$R_{\theta JC}$	1.05	°C/W
Thermal Resistance, Junction to case for IGBT	$R_{\theta JC}$	0.53	°C/W
Maximum Temperature for Soldering,wave soldering 1.6mm (0.063in.) from case for 10s	$T_L$	260	°C
Junction Temperature Range	$T_J$	-40 ~ +175	°C
Storage Temperature Range	$T_{STG}$	-55 ~ +150	°C

### Electrical characteristics of the IGBT (T<sub>J</sub>=25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit	
<b>Static Characteristics</b>							
Collector-Emitter Breakdown Voltage	$V_{(BR)CES}$	$V_{GE} = 0V, I_{CE} = 250\mu A$	650			V	
Collector-Emitter Leakage Current	$I_{CES}$	$V_{GE} = 0V, V_{CE} = 650V$			0.25	mA	
		$V_{GE} = 0V, V_{CE} = 650V, T_J = 150^\circ\text{C}$			3		
Gate to Emitter Leakage Current	$I_{GES}$	$V_{GE} = \pm 20V, V_{CE} = 0V$			100	nA	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{GE} = 15V, I_C = 50A$	1.3	1.6	1.9	V	
		$V_{GE} = 15V, I_C = 50A, T_J = 125^\circ\text{C}$		1.8			
		$V_{GE} = 15V, I_C = 50A, T_J = 150^\circ\text{C}$		1.9			
Gate Threshold Voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}, I_C = 0.5mA$	3.8	4.8	5.8	V	
<b>Dynamic characteristics</b>							
Input Capacitance	$C_{ies}$	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		2.83		nF	
Reverse Transfer Capacitance	$C_{res}$			0.02		nF	
Total Gate Charge	$Q_g$	$V_{CC} = 520V, V_{GE} = 15V, I_C = 50A$		0.14		uC	
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 400V, V_{GE} = -5V \sim 15V, I_C = 50A, R_G = 10\Omega, \text{Inductive Load}$		24		nS	
Turn-on rise time	$t_r$			31			
Turn-off delay time	$t_{d(off)}$			74			
Turn-off fall time	$t_f$			35			
Turn-On Switching energy	$E_{on}$			2.05			mJ
Turn-Off Switching energy	$E_{off}$			0.36			
Total Switching energy	$E_{ts}$		2.47				
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 400V, V_{GE} = -5V \sim 15V, I_C = 50A, R_G = 10\Omega, \text{Inductive Load, } T_J = 125^\circ\text{C}$		24		nS	
Turn-on rise time	$t_r$			42			
Turn-off delay time	$t_{d(off)}$			82			
Turn-off fall time	$t_f$			41			
Turn-On Switching energy	$E_{on}$			2.11			mJ
Turn-Off Switching energy	$E_{off}$			0.44			
Total Switching energy	$E_{ts}$		2.56				
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 400V, V_{GE} = -5V \sim 15V, I_C = 50A, R_G = 10\Omega, \text{Inductive Load, } T_J = 150^\circ\text{C}$		25		nS	
Turn-on rise time	$t_r$			48			
Turn-off delay time	$t_{d(off)}$			88			
Turn-off fall time	$t_f$			44			
Turn-On Switching energy	$E_{on}$			2.19			mJ
Turn-Off Switching energy	$E_{off}$			0.47			
Total Switching energy	$E_{ts}$		2.66				

### Electrical characteristics of the Diode ( $T_j=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Diode Forward Voltage	$V_{FM}$	$I_F=50\text{A}$		1.60	2.00	V
		$I_F=50\text{A}, T_j=125^\circ\text{C}$		1.50		
		$I_F=50\text{A}, T_j=150^\circ\text{C}$		1.40		
Reverse Recovery Current	$I_{rr}$	$I_F=50\text{A}, V_R=400\text{V}, -di/dt=450\text{A/us}$		15		A
Diode reverse recovery time	$t_{rr}$			148		ns
Reverse Recovery Charge	$Q_{rr}$			1.58		$\mu\text{C}$
Reverse recovery energy	$E_{rec}$			0.29		mJ
Reverse Recovery Current	$I_{rr}$	$I_F=50\text{A}, V_R=400\text{V}, -di/dt=450\text{A/us}, T_j=125^\circ\text{C}$		21		A
Diode reverse recovery time	$t_{rr}$			183		ns
Reverse Recovery Charge	$Q_{rr}$			2.54		$\mu\text{C}$
Reverse recovery energy	$E_{rec}$			0.65		mJ
Reverse Recovery Current	$I_{rr}$	$I_F=50\text{A}, V_R=400\text{V}, -di/dt=450\text{A/us}, T_j=150^\circ\text{C}$		24		A
Diode reverse recovery time	$t_{rr}$			218		ns
Reverse Recovery Charge	$Q_{rr}$			3.59		$\mu\text{C}$
Reverse recovery energy	$E_{rec}$			0.79		mJ

## Typical Characteristics

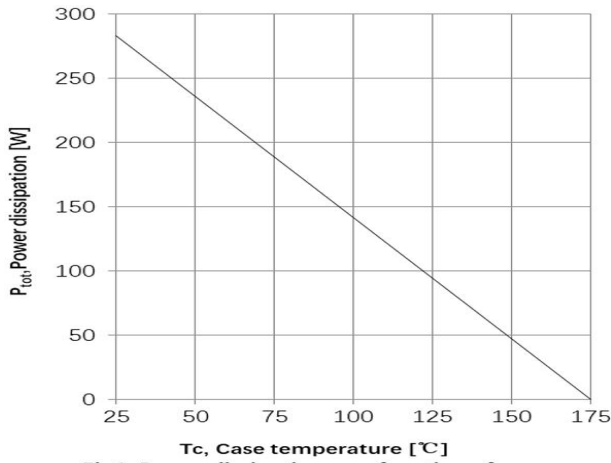


Fig1. Power dissipation as a function of case temperature ( $T_j \leq 175^\circ\text{C}$ )

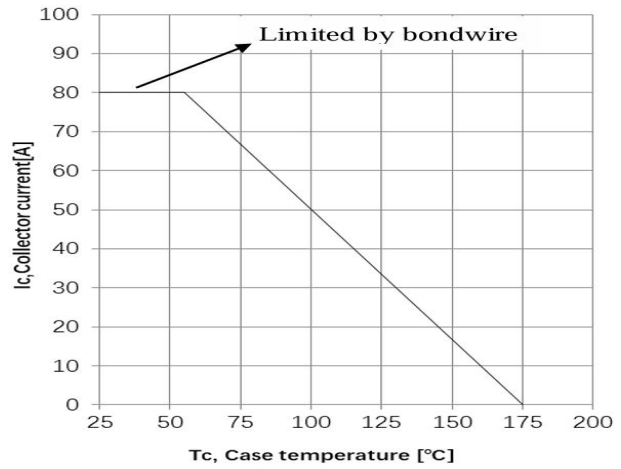


Fig2. Collector current as a function of case temperature ( $V_{ge} \geq 15\text{V}$ ,  $T_j \leq 175^\circ\text{C}$ )

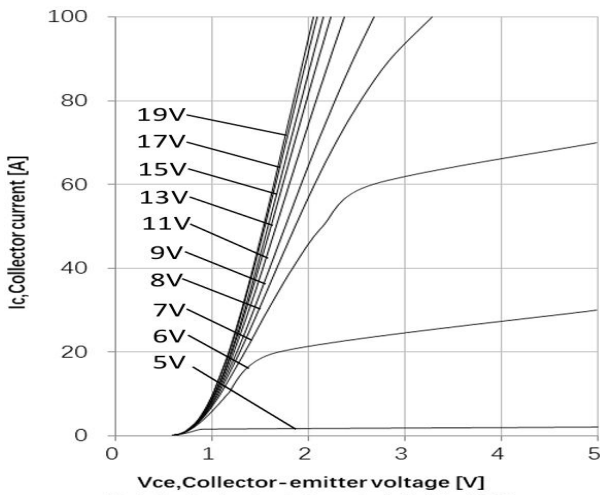


Fig3. Typical output characteristic ( $T_j = 25^\circ\text{C}$ )

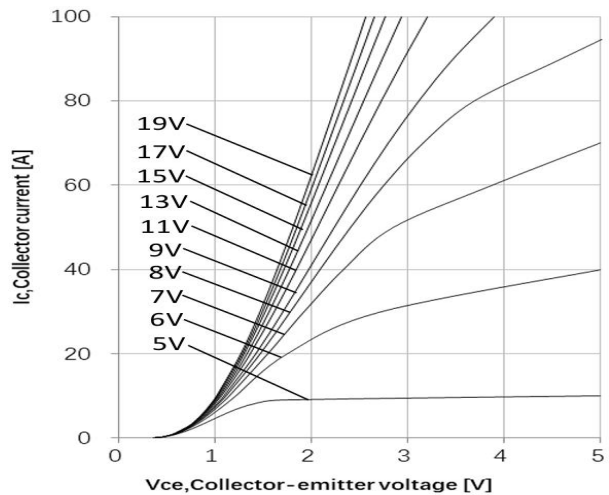


Fig4. Typical output characteristic ( $T_j = 150^\circ\text{C}$ )

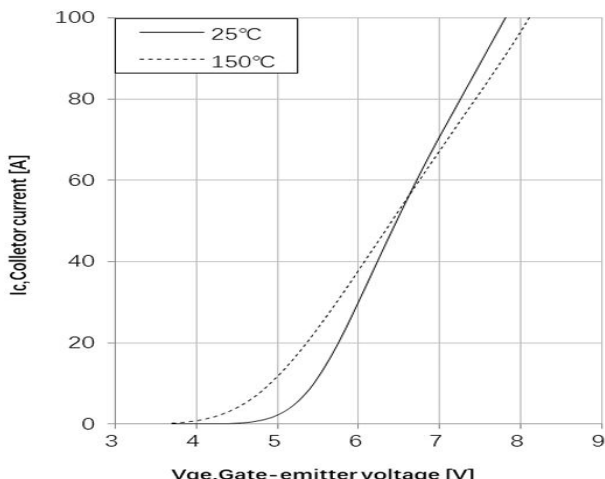


Fig5. Typical transfer characteristic ( $V_{ce} = 20\text{V}$ )

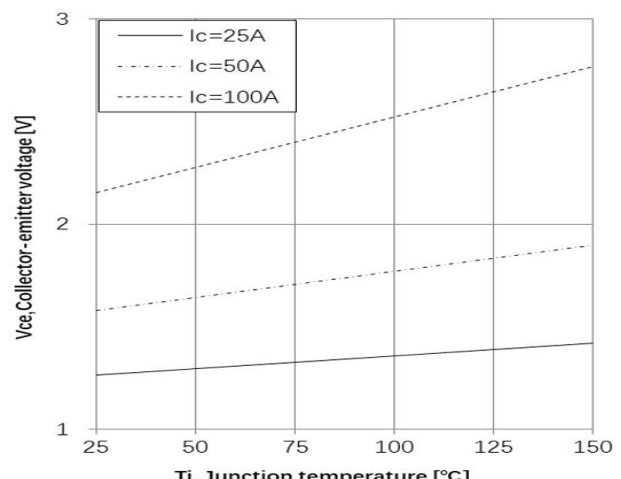


Fig6. Typical collector-emitter saturation voltage as a function of junction temperature ( $V_{ge} = 15\text{V}$ )

**Typical Characteristics**

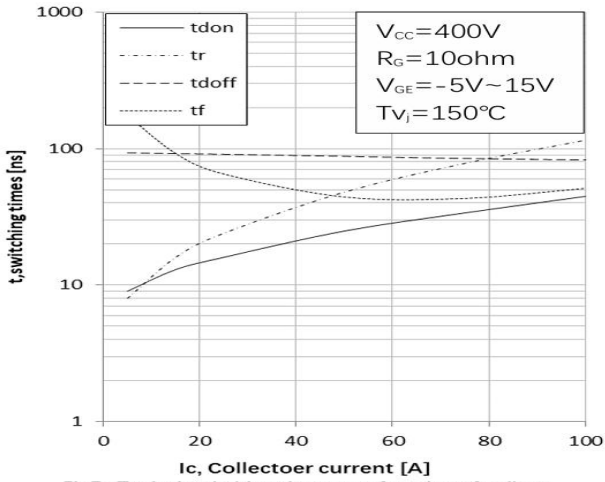


Fig7. Typical switching times as a function of collector current

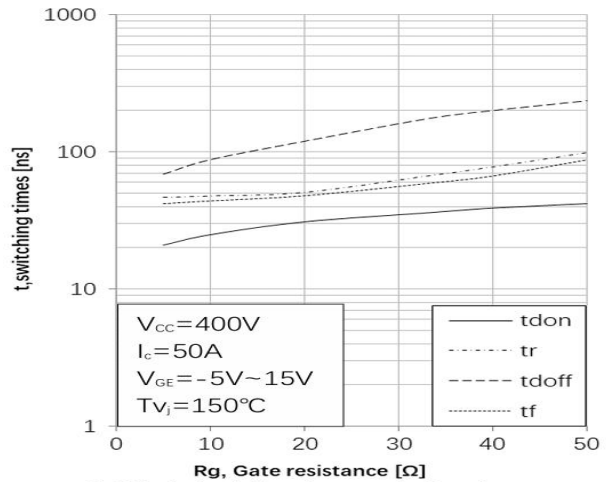


Fig8. Typical switching times as a function of gate resistance

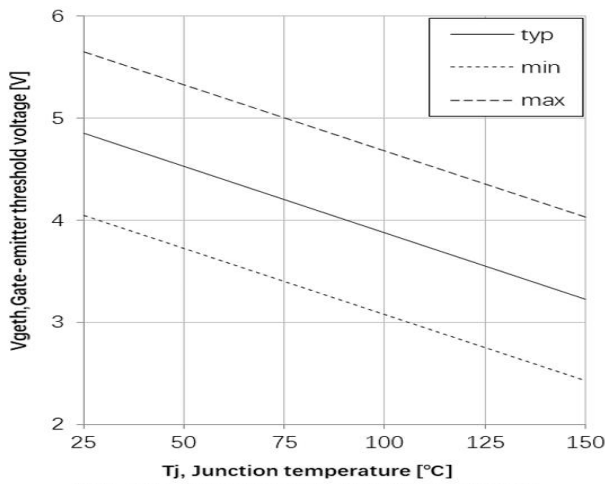


Fig9. Gate-emitter threshold voltage as a function of junction temperature(I<sub>c</sub>=0.5mA)

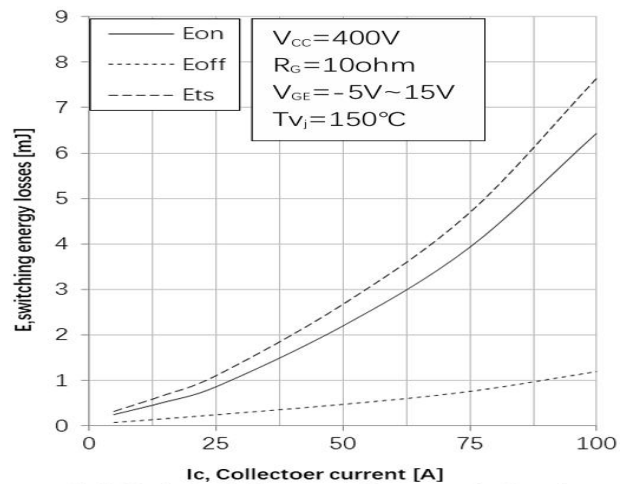


Fig10. Typical switching energy losses as a function of collector current

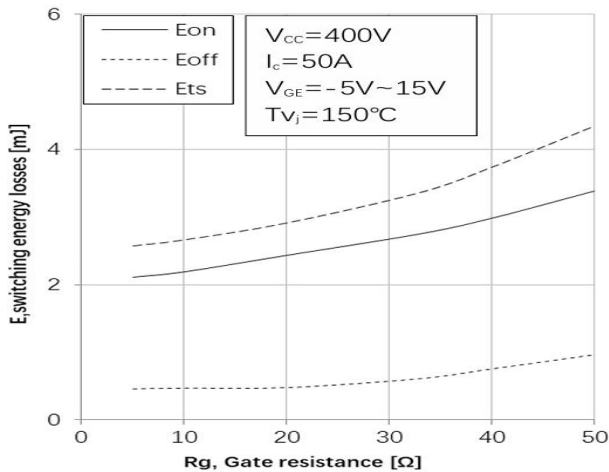


Fig11. Typical switching energy losses as a function of gate resistance

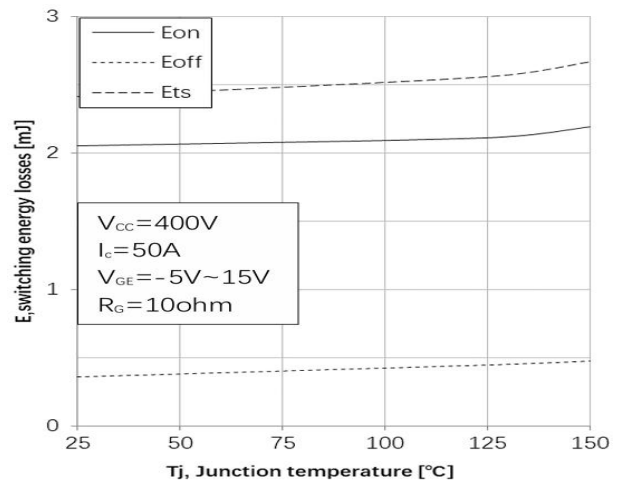


Fig12. Typical switching energy losses as a function of junction temperature

**Typical Characteristics**

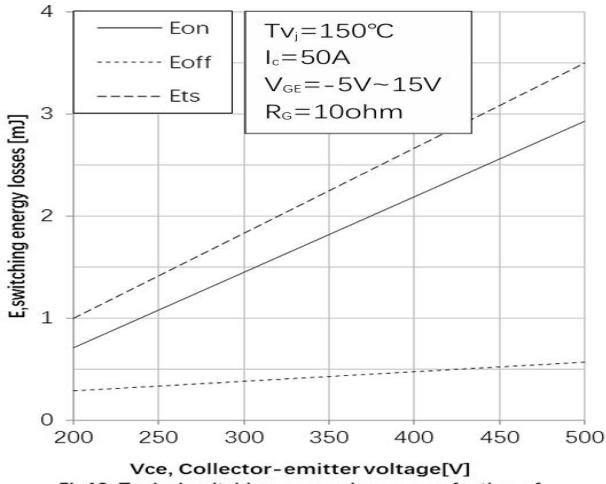


Fig13. Typical switching energy losses as a function of collector-emitter voltage

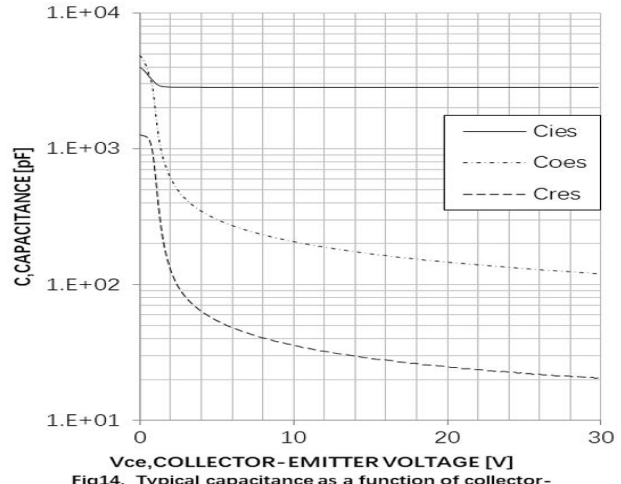


Fig14. Typical capacitance as a function of collector-emitter voltage

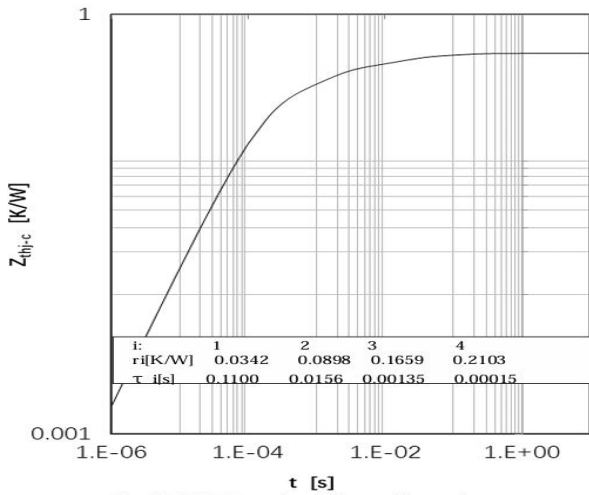


Fig 15. IGBT Transient Thermal Impedance

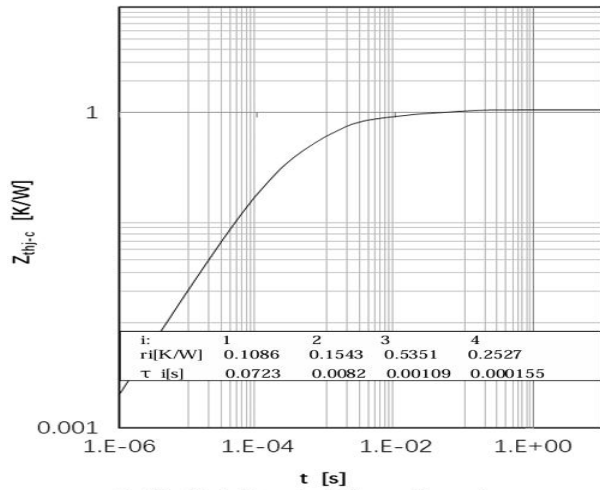


Fig 16. Diode Transient Thermal Impedance

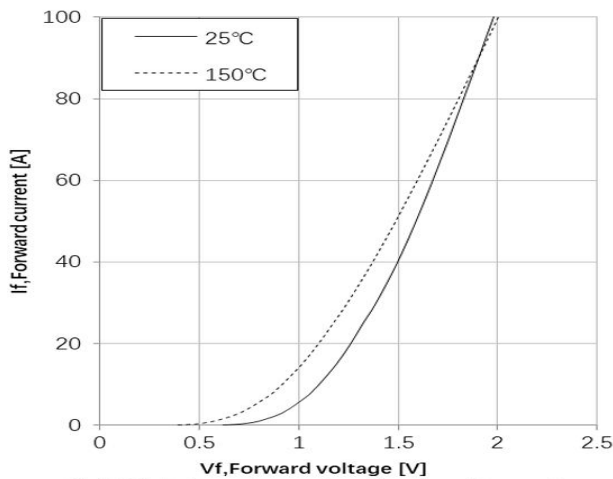


Fig17. Diode forward current as a function of forward voltage

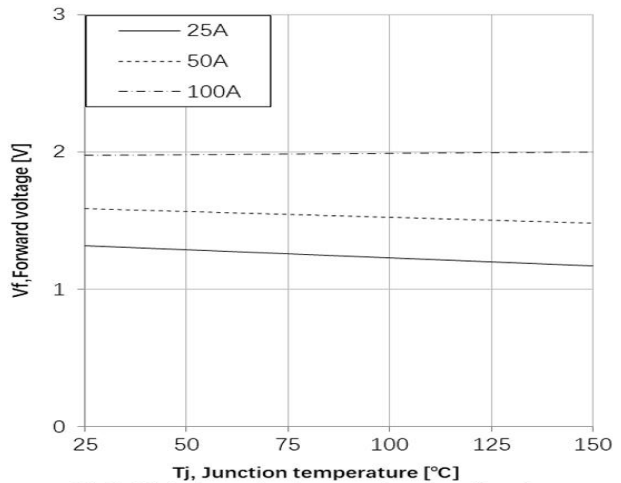
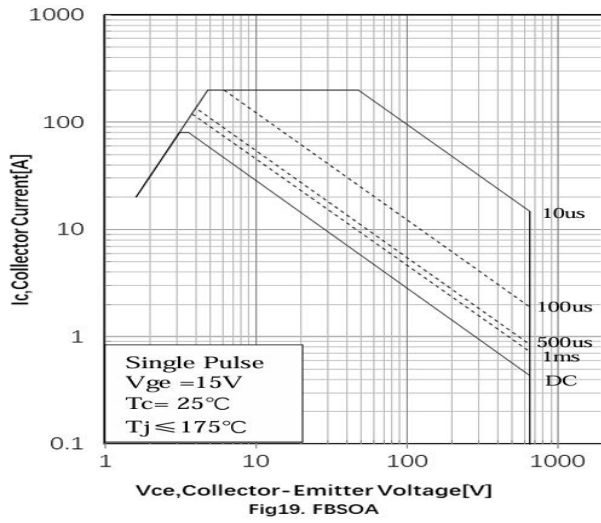


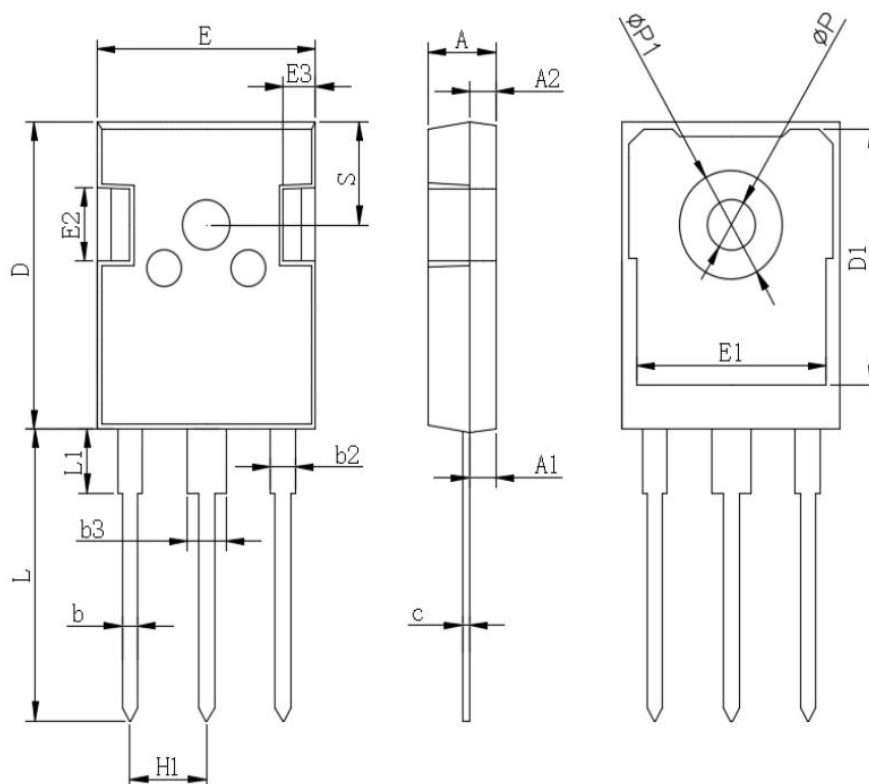
Fig18. Diode forward voltage as a function of junction temperature

**Typical Characteristics**





### TO-247AB Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.800	5.200	0.189	0.205
A1	2.210	2.610	0.087	0.103
A2	1.850	2.150	0.073	0.085
b	1.000	1.400	0.039	0.055
b2	1.910	2.210	0.075	0.087
b3	2.800	3.200	0.110	0.126
C	0.500	0.700	0.020	0.028
D	20.700	21.300	0.815	0.839
D1	16.250	16.850	0.640	0.663
E	15.500	16.100	0.610	0.634
E1	13.000	13.600	0.512	0.535
E2	4.800	5.200	0.189	0.205
E3	2.300	2.700	0.091	0.106
L	19.620	20.220	0.772	0.796
L1	-	4.300	-	0.169
φP	3.400	3.800	0.134	0.150
φP1	-	7.300	-	0.287
S	6.150 TYP		0.242 TYP	
H1	5.440 TYP		0.214 TYP	